

Search Notes

Application/Control No.

10/826,236

Examiner

Ren L. Yan

Applicant(s)/Patent under
Reexamination

HASHIMOTO ET AL.

Art Unit

2854

SEARCHED

Class	Subclass	Date	Examiner
101	150	4/6/2006	RY
	152		
	153		
	154		
	161		
	165		
	170		
	395		
	401.1		
430	307		
	310		
	396		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
interference search print out		4/6/2006	RY

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR